

<b>Notice of References Cited</b>	Application/Control No. 10/681,104		Applicant(s)/Patent Under Reexamination RYU ET AL.	
	Examiner TAN TRINH		Art Unit 2618	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,269,075	07-2001	Tran, Jean-Marie	370/206
*	B	US-2001/0048712	12-2001	Tomita et al.	375/148
*	C	US-2004/0028121	02-2004	Fitton, Michael P.	375/144
*	D	US-2003/0108090	06-2003	Giancola, Diego	375/148
*	E	US-2004/0240532	12-2004	Reznik et al.	375/148
*	F	US-2004/0120387	06-2004	Bultan et al.	375/149
*	G	US-2003/0123528	07-2003	Hackett, William C.	375/148
*	H	US-2004/0170220	09-2004	Hackett, William C.	375/148
*	I	US-6,154,487	11-2000	Murai et al.	375/150
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)\*  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.